

**Search Notes**

Application/Control No.

10/760,505

Examiner

Lois Zheng

Applicant(s)/Patent under  
Reexamination

HIRAIWA ET AL.

Art Unit

1742

**SEARCHED**

Class	Subclass	Date	Examiner
204	243.1	5/18/2007	LLZ
204	241-242	5/18/2007	LLZ
204	274	5/18/2007	LLZ
205	230	5/18/2007	LLZ
205	354	5/18/2007	LLZ
205	356	5/18/2007	LLZ
205	359	5/18/2007	LLZ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
204	243.1	5/18/2007	LLZ
204	274	5/18/2007	LLZ
205	359	5/18/2007	LLZ

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventorship search	5/18/2007	LLZ
Updated EAST search	5/18/2007	LLZ
Consulted with Harry Wilkins, III	5/18/2007	LLZ